

Notice of References Cited

Application/Control No.

10/593,883

Applicant(s)/Patent Under
Reexamination
DUGGAN ET AL.

Examiner

M. Lee

Art Unit

2622

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,860,720	01-1999	Negishi et al.	353/74
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 08051582 A	02-1996	Japan	HAYASHI, SHUNEI	
	O	JP 02094784 A	04-1990	Japan	IDE et al.	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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